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(54) **PROCESS FOR MAKING ELECTRODE PAIRS**

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See application file for complete search history.

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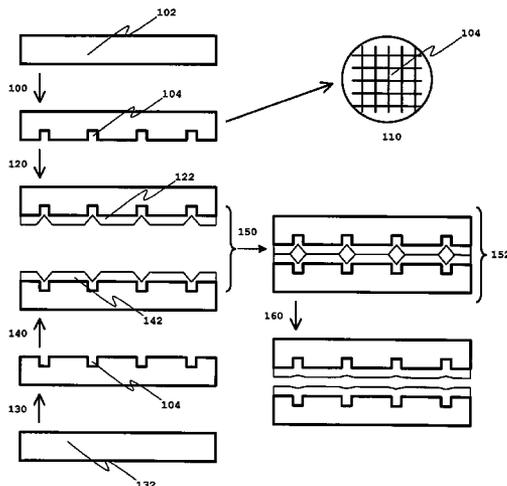
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(57) **ABSTRACT**

The present invention is a process for making a matching pair of surfaces, which involves creating a network of channels on one surface of two substrate. The substrates are then coated with one or more layers of materials, the coating extending over the regions between the channels and also partially into the channels. The two coated surfaces are then contacted and pressure is applied, which causes the coatings to be pressed into the network of channels, and surface features on one of the layers of material creates matching surface features in the other, and vice versa. It also results in the formation of a composite. In a final step, the composite is separated, forming a matching pair of surfaces.

17 Claims, 2 Drawing Sheets



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Figure 1

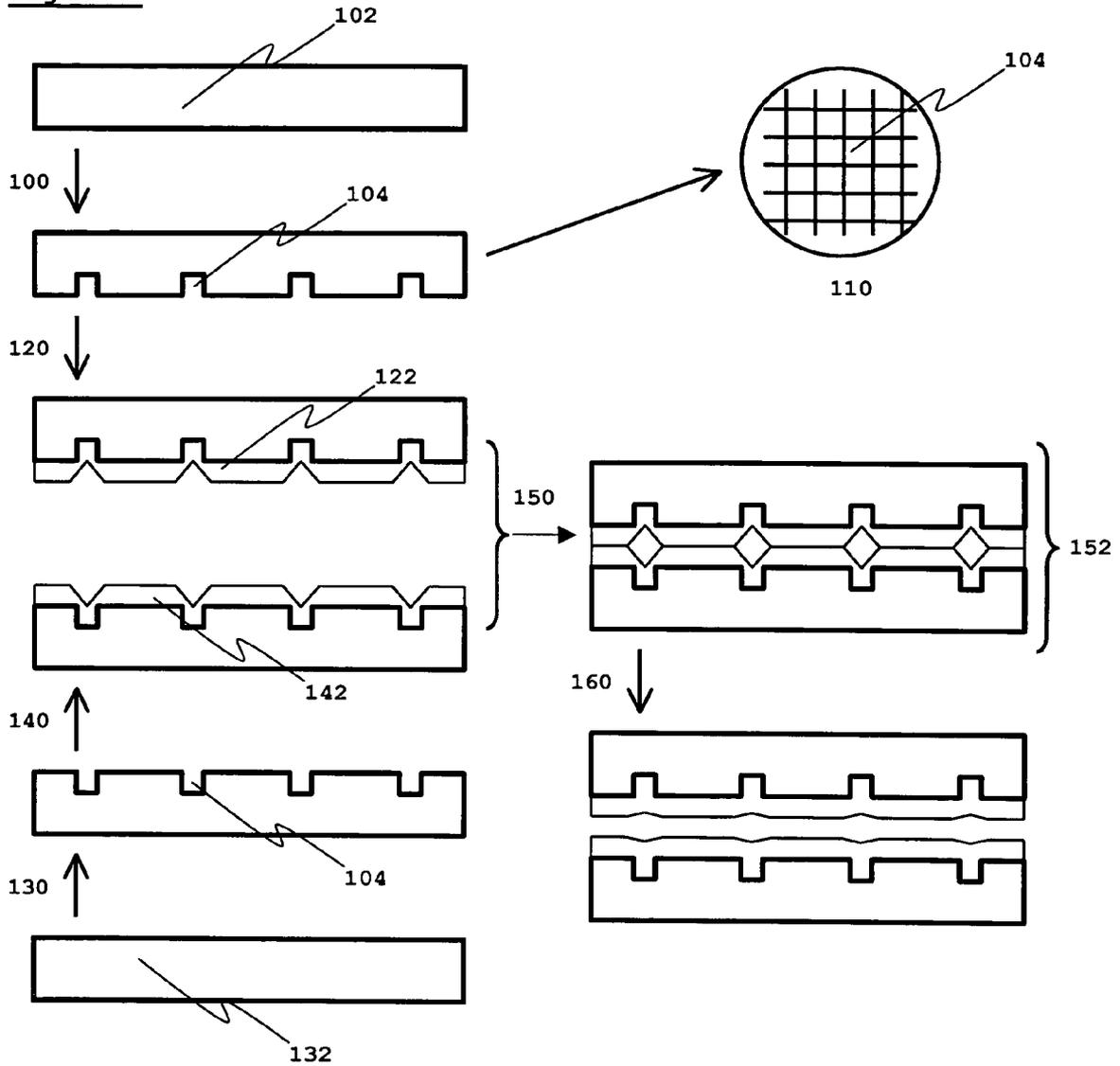
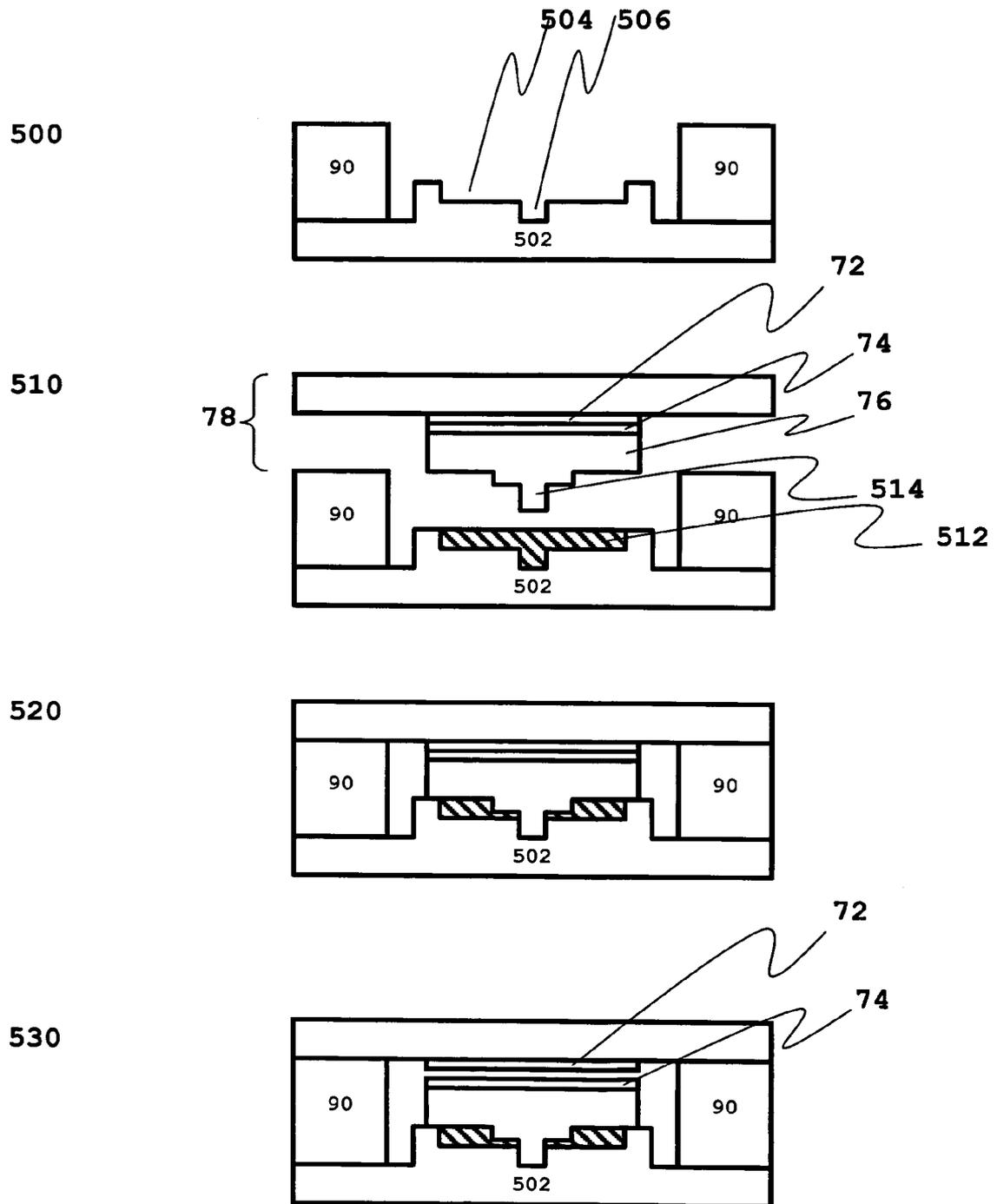


Figure 2



PROCESS FOR MAKING ELECTRODE PAIRSCROSS-REFERENCE TO RELATED
APPLICATIONS

This application claims the benefit of U.K. Provisional Application No. GB0423534.7, filed Oct. 25, 2004. This application is a continuation-in-part of U.S. patent application Ser. No. 10/234,498, filed 3 Sep. 2002, now U.S. Pat. No. 7,140,102 which claims the benefit of U.S. Provisional Application No. 60/316,918, filed 2 Sep. 2001. This application is a Continuation-in-Part of U.S. patent application Ser. No. 10/507,273, now U.S. Pat. No. 7,169,006 which is the U.S. national stage application of International Application PCT/US03/07015, filed Mar. 6, 2003, which international application was published on Oct. 30, 2003, as International Publication WO03090245 in the English language. The International Application claims the benefit of U.S. Provisional Application No. 60/362,494, filed Mar. 6, 2002, and U.S. Provisional Application No. 60/373,508, filed Apr. 17, 2002. This application is a Continuation-in-Part of U.S. patent application Ser. No. 10/823,483, filed 12 Apr. 2004, now abandoned which is a Continuation-in-Part of U.S. patent application Ser. No. 09/481,803, filed 31 Aug. 1998, U.S. Pat. No. 6,720,704, which is a Continuation-in-Part of U.S. patent application Ser. No. 08/924,910, filed 8 Sep. 1997, abandoned. The above-mentioned patent applications are assigned to the assignee of the present application and are herein incorporated in their entirety by reference.

BACKGROUND OF THE INVENTION

This invention relates to a method for making electrode pairs.

The use of individual actuating devices to control the separation of electrodes in a gap diode is disclosed in U.S. Pat. No. 6,720,704.

The use of composite materials as matching electrode pair precursors is disclosed in US2003/0068431. The approach comprises the steps of fabricating a first electrode with a substantially flat surface; placing over the first electrode a second material that comprises a material that is suitable for use as a second electrode, and separating the composite so formed along the boundary of the two layers into two matched electrodes. The separation step involves the use of an electrical current, thermal stresses, or mechanical force. A similar approach is also disclosed in US2004/0195934.

BRIEF SUMMARY OF THE INVENTION

From the foregoing, it may be appreciated that a need has arisen for a simpler, more direct approach for manufacturing matched pairs of surfaces.

The present invention is a process for making a matching pair of surfaces, which involves creating a network of channels on one surface of two substrate. The substrates are then coated with one or more layers of materials, the coating extending over the regions between the channels and also partially into the channels. The two coated surfaces are then contacted and pressure is applied, which causes the coatings to be pressed into the network of channels, and surface features on one of the layers of material creates matching surface features in the other, and vice versa. It also results in the

formation of a composite. In a final step, the composite is separated, forming a matching pair of surfaces.

BRIEF DESCRIPTION OF THE SEVERAL
VIEWS OF THE DRAWING

For a more complete explanation of the present invention and the technical advantages thereof, reference is now made to the following description and the accompanying drawing in which:

FIG. 1 shows a diagrammatic overview of the process of the present invention.

FIG. 2 is a schematic showing a process for the manufacture of a diode device having a tubular housing/actuator.

DETAILED DESCRIPTION OF THE INVENTION

In the disclosure which follows, when surface features of two facing surfaces of electrodes are described as "matching" it means that where one surface has an indentation, the other surface has a protrusion and vice versa. Thus when "matched" the two surfaces are substantially equidistant from each other throughout their operating range.

Embodiments of the present invention and their technical advantages may be better understood by referring to FIG. 1, in which a first substrate **102** is provided. Preferably the substrate comprises silicon, though other materials commonly used, such as without limitation glass, silica or molybdenum may be utilized.

In a first step **100**, a network of channels **104** is created in the surface of the substrate. The channels may be formed by any conventional method, including but not limited to photolithography and ion beam milling. Typically the channels have a depth of 100 nm, and the spacing between the channels is typically 500 μm . Other depths and spacings may be conveniently employed, the key feature of this part of the invention is that the channels are of sufficient depth and spacing to accommodate material pushed laterally in step **150** below. In a preferred embodiment the channels are arranged in a grid-like formation as shown in the plan view **110**. However, other arrangements are possible; the key feature of this part of the invention is that the channels are interconnected into a network of channels.

In a second step **120**, a first material **122** is deposited on a surface of the substrate. The first material comprises material that is suitable for use as an electrode. Preferably, the first material comprises silver. Other materials include gold, platinum, palladium, tungsten or chromium. Whilst step **120** is shown as a single step, it may comprise multiple steps. For example, in a preferred embodiment, a layer of silver is first deposited. Then, the surface of the layer of silver is oxidized to form a layer of silver oxide. Subsequently the layer of silver oxide is caesiated to form a layer of AgCsO on the surface of the first material. The scope of the invention is not limited to the use of these materials, and the use of other materials commonly employed in wafer applications are encompassed within the present invention.

In a third step **130**, a second substrate **132** is provided, and in a step analogous to step **100**, a network of channels is created in the surface of the substrate. Preferably the channels have a depth of 100 nm, and the spacing between the channels is typically 500 μm . Other depths and spacings may be conveniently employed, the key feature of this part of the invention is that the channels are of sufficient depth and spacing to accommodate material pushed laterally in step **150** below. In a preferred embodiment the channels are arranged in a grid-like formation as shown in the plan view **110**. However, other

arrangements are possible; the key feature of this part of the invention is that the channels are interconnected into a network of channels.

In a fourth step **140**, a second material **142** is deposited on a surface of the substrate. The second material comprises material that is suitable for use as an electrode. Preferably, the second material comprises silver. Other materials include gold, platinum, palladium, tungsten or chromium. Whilst step **140** is shown as a single step, it may comprise multiple steps. For example, in a preferred embodiment, a layer of silver is first deposited. Then, a layer of an insulator material, as disclosed in WO04049379, such as C_3N_4 or Al_4Si_3 may be formed on the layer of silver. The scope of the invention is not limited to the use of these materials, and the use of other materials commonly employed in wafer applications are encompassed within the present invention.

In a fifth step **150**, the first substrate and the one or more layers deposited thereon, and the second substrate and the one or more layers deposited thereon are pressed together with sufficient force that surface features on material **122** are 'matched' on surface material **142**, and surface features on material **142** are 'matched' on surface material **122**. Substrates may be pressed together by means of cold pressing, as known in the art, wherein pressure is applied by means of a piston at temperatures below the melting point of the electrode materials. Substrates may also be pressed together by the application of cold isostatic pressure, as known in the art. Typical pressures employed in this process differ depending on the specific materials used but are of the order of 10-120 GPa. The duration for which the substrates are pressed together is in the order of a few minutes and the temperature typically not much above ambient temperature, i.e. about 25 degree C.

During the pressing process, material displaced is able to be squeezed into the network of channels. Without the network of channels, the surface replication step will not work, as there is nowhere for displaced material to be squeezed.

Depending on the nature of the layers deposited on the two substrates, the two substrates may need to be heated (to reduce the hardness of the layers) or cooled (to increase the hardness of the layers).

Preferably, all the steps above are performed in a substantially evacuated atmosphere.

In a sixth step **160**, the composite is split between layers **122** and **142** to form two electrodes in which surface features of one are reflected in the other; thus where layer **122** has a protruding feature, layer **142** has a matching indented feature, and vice versa. This relationship, of course, does not hold in the regions of the channels. The separation step may be achieved, for example and without limitation, by applying an electrical current through the materials to separate the electrodes along the boundary of two layers; by cooling or heating the materials, so that the differential in the Thermal Coefficient of Expansion (TCE) between two materials breaks the adhesive bond between the two materials; by forcible separation of the two materials to break the adhesion between the two materials, for example by means of piezoelectric actuators as known in the art; or by the addition or removal of energy, for example by means of an ultrasonic treatment step. A specific example is given below.

In a preferred embodiment the force with which the two substrates are pressed together in step **150** is sufficient that the two substrates and the one or more layers deposited thereupon form a single composite **152**. According to this embodiment, during a sixth step **160**, the temperature of the composite is altered such that the composite splits between layers **122** and **142** to form two electrodes in which surface features of one

are reflected in the other; thus where layer **122** has a protruding feature, layer **142** has a matching indented feature, and vice versa. For example without limitation, a composite formed from the materials described above (Ag/AgO/AgCsO on substrate **102** and insulator/Ag on substrate **122**) is cooled further, which causes the composite to split into two halves along the junction between the AgCsO layer and the insulator layer.

Thus two matching electrodes are formed, which may be utilized in devices requiring close-spaced electrodes, such as the tunnelling devices described in U.S. Pat. No. 6,720,704.

For example, and without limitation, first substrate **102** may comprise n-type doped silicon, with conductivity of the order of 0.05 Ohm cm. A 0.1 μ m thick titanium film, comprising first material **122**, is deposited over the silicon substrate using DC magnetron sputtering method. Second substrate **132** may comprise copper, coated with silver, corresponding to second material **142**. A network of channels is formed on the surfaces of both the silicon and copper substrates by means of focused ion beam milling, as known in the art. The titanium coated silicon substrate and silver coated copper substrate are then pressed together by way of cold pressing with applied pressure of 110 GPa. The composite formed thereby can be split by way of application of a current of the order of 0.1 snips/cm² and 0.1 V. Alternatively, piezoelectric actuators may be used to draw the electrodes apart. The composite may also be cooled to 0° C. or heated to 40° C., whereby the silver and titanium layers separate due to their different coefficients of thermal expansion.

For example and without limitation, the composite may be housed in the device described in WO03090245, as shown in FIG. 2 and as disclosed below. Referring now to FIG. 2, composite **78** is composite **152** depicted in FIG. 1 having a further layer of copper **76** grown electrochemically by conventional processes on substrate **132**. In step **500** a first substrate **502** is brought into contact with a polished end of a quartz tube **90**. Substrate **502** is any material which may be bonded to quartz, and which has a similar thermal expansion coefficient to quartz. Preferably substrate **502** is molybdenum, or silicon doped to render at least a portion of it electrically conductive. Substrate **502** has a depression **504** across part of its surface. Substrate **502** also has a locating hole **506** in its surface. In step **510**, liquid metal **512**, is introduced into depression **502**. The liquid metal is a metal having a high temperature of vaporization, and which is liquid under the conditions of operation of the device. The high temperature of vaporization ensures that the vapor from the liquid does not degrade the vacuum within the finished device. Preferably the liquid metal is a mixture of Indium and Gallium. Composite **78** is positioned so that alignment pin **514** is positioned above locating hole **506**. Alignment pin **514**, which is pre-machined, is placed on the composite near the end of the electrolytic growth phase; this results in its attachment to the layer of copper **76**. The diameter of the alignment pin is the same as the diameter of the locating hole. In step **520**, the polished silicon periphery of the composite **78** is contacted with the other polished end of the quartz tube **90**; at the same time, the attachment pin seats in locating hole. During this step, substrate **502** is heated so that locating hole expands; when the assemblage is subsequently cooled, there is a tight fit between the alignment pin and the locating hole. High pressure is applied to this assemblage, which accelerates the chemical reaction between the polished silicon periphery of the composites and the polished ends of the quartz tube, bonding the polished surfaces to form the assemblage depicted in step **520**. In step **530**, the assemblage is heated, and a signal applied to the quartz tube to cause the composite to open as

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shown, forming two electrodes, **72** and **74**. This is analogous to step **160** and the electrode composite opens as shown, forming a pair of matching electrodes, **72** and **74**. During the opening process, the tight fit between the alignment pin and the locating hole ensures that the electrodes **72** and **74** do not slide relative to one another.

Other housing designs and integration approaches may be adopted, and the scope of the present invention is not limited by the housing and integration example disclosed above.

Although the above specification contains many specificities, these should not be construed as limiting the scope of the invention but as merely providing illustrations of some of the presently preferred embodiments of this invention.

Devices made according to the present invention may be used in diode devices, vacuum diode devices, heat pumps, any other devices that are based on tunneling effects, and the like.

While this invention has been described with reference to numerous embodiments, it is to be understood that this description is not intended to be construed in a limiting sense. Various modifications and combinations of the illustrative embodiments will be apparent to persons skilled in the art upon reference to this description. It is to be further understood, therefore, that numerous changes in the details of the embodiments of the present invention and additional embodiments of the present invention will be apparent to, and may be made by, persons of ordinary skill in the art having reference to this description. It is contemplated that all such changes and additional embodiments are within the spirit and true scope of the invention as claimed below.

All publications and patent applications mentioned in this specification are indicative of the level of skill of those skilled in the art to which this invention pertains. All publications and patent applications are herein incorporated by reference to the same extent as if each individual publication or patent application was specifically and individually indicated to be incorporated by reference.

The invention claimed is:

1. A process for making a matching pair of surfaces comprising the steps:
 - a) creating a network of channels on a surface of a first substrate;
 - b) coating a layer of a first material over said surface of said first substrate;
 - c) creating a network of channels on a surface of a second substrate;
 - d) coating a layer of a second material over said surface of said second substrate;
 - e) contacting said layer of a first material and said layer of a second material;
 - f) applying pressure across said layer of a first material and said layer of a second material; pressing said first mate-

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- g) separating said composite whereby a matching pair of surfaces is formed, wherein where one surface has an indentation the other surface has a protrusion so that the two surfaces are substantially equidistant from each other.
2. The process of claim **1** wherein said step of creating a network of channels comprises photolithography.
3. The process of claim **1** wherein said step of creating a network of channels comprises ion beam milling.
4. The process of claim **1** wherein said step of coating a layer of a first material comprises multiple coating steps.
5. The process of claim **1** wherein said step of coating a layer of a first material comprises the steps:
 - a) depositing a layer of silver;
 - b) oxidising partially said layer of silver and forming a layer of silver oxide; and
 - c) exposing said layer of silver oxide to caesium and forming a layer of caesiated silver oxide.
6. The process of claim **1** wherein said first material comprises more than one material.
7. The process of claim **1** wherein said step of coating a layer of a second material comprises multiple coating steps.
8. The process of claim **1** wherein said step of coating a layer of a second material comprises the steps:
 - a) depositing a layer of silver, and
 - b) depositing a layer of an insulator on said layer of silver.
9. The process of claim **8** wherein said insulator material comprises a material selected from the group consisting of: aluminum oxide (Al_2O_3), carbon nitride (C_3N_4), and aluminum silicide (Al_4Si_3).
10. The process of claim **1** wherein said second material comprises more than one material.
11. The process of claim **1** wherein said network of channels is characterised by having a depth of approximately 100 nm and a spacing between the channels is approximately 500 μm .
12. The method of claim **1** wherein said step of separating said composite comprises applying an electric current between said first material and said second material.
13. The method of claim **1** wherein said step of separating said composite comprises heating said composite.
14. The method of claim **1** wherein said step of separating said composite comprises cooling said composite.
15. The method of claim **1** wherein said step of separating said composite comprises applying or removing energy to or from the composite.
16. The method of claim **1** wherein said step of separating said composite comprises applying a mechanical force.
17. A pair of matching electrodes made according to the method of claim **1**.

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